Dual/Quad Low Power, High Speed JFET Operational Amplifiers

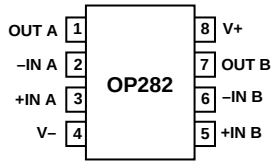
OP282/OP482

FEATURES
High Slew Rate: 9 V/μs
Wide Bandwidth: 4 MHz
Low Supply Current: 250 μA/Amplifier
Low Offset Voltage: 3 mV
Low Bias Current: 100 pA
Fast Settling Time
Common-Mode Range Includes V+
Unity Gain Stable

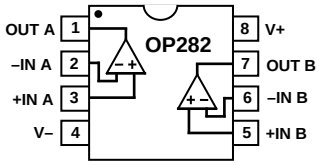
APPLICATIONS
Active Filters
Fast Amplifiers
Integrators
Supply Current Monitoring

PIN CONNECTIONS

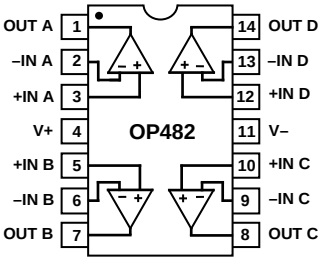
8-Lead Narrow-Body SOIC (S Suffix)



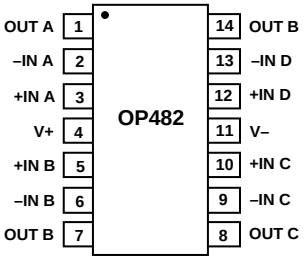
8-Lead Epoxy DIP (P Suffix)



14-Lead Epoxy DIP (P Suffix)



14-Lead Narrow-Body SOIC (S Suffix)



GENERAL DESCRIPTION

The OP282/OP482 dual and quad operational amplifiers feature excellent speed at exceptionally low supply currents. Slew rate exceeds 7 V/μs with supply current under 250 μA per amplifier. These unity gain stable amplifiers have a typical gain bandwidth of 4 MHz.

The JFET input stage of the OP282/OP482 insures bias current is typically a few picoamps and below 500 pA over the full temperature range. Offset voltage is under 3 mV for the dual and under 4 mV for the quad.

With a wide output swing, within 1.5 volts of each supply, low power consumption and high slew rate, the OP282/OP482 are ideal for battery-powered systems or power restricted applications. An input common-mode range that includes the positive supply makes the OP282/OP482 an excellent choice for high-side signal conditioning.

The OP282/OP482 are specified over the extended industrial temperature range. Both dual and quad amplifiers are available in plastic and ceramic DIP plus SOIC surface mount packages.

REV. B

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Tel: 617/329-4700 **Fax: 617/326-8703**

OP282/OP482–SPECIFICATIONS

ELECTRICAL CHARACTERISTICS (@ V_S = ±15.0 V, T_A = +25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
INPUT CHARACTERISTICS						
Offset Voltage	V_{OS}	OP282		0.2	3	mV
		OP282, –40 ≤ T_A ≤ +85°C			4.5	mV
Offset Voltage	V_{OS}	OP482		0.2	4	mV
		OP482, –40 ≤ T_A ≤ +85°C			6	mV
Input Bias Current	I_B	V_{CM} = 0 V		3	100	pA
		V_{CM} = 0 V, Note 1			500	pA
Input Offset Current	I_{OS}	V_{CM} = 0 V		1	50	pA
		V_{CM} = 0 V, Note 1			250	pA
Input Voltage Range			–11		+15	V
Common-Mode Rejection	CMR	–11 V ≤ V_{CM} ≤ +15 V, –40 ≤ T_A ≤ +85°C	70	90		dB
Large Signal Voltage Gain	A_{VO}	R_L = 10 kΩ	20			V/mV
		R_L = 10 kΩ, –40 ≤ T_A ≤ +85°C	15			V/mV
Offset Voltage Drift	$\Delta V_{OS}/\Delta T$			10		µV/°C
Bias Current Drift	$\Delta I_B/\Delta T$			8		pA/°C
OUTPUT CHARACTERISTICS						
Output Voltage Swing	V_O	R_L = 10 kΩ	–13.5	±13.9	13.5	V
Short Circuit Limit	I_{SC}	Source	3	10		mA
		Sink	–8	–12		mA
Open-Loop Output Impedance	Z_{OUT}	f = 1 MHz		200		Ω
POWER SUPPLY						
Power Supply Rejection Ratio	PSRR	V_S = ±4.5 V to ±18 V,				
		–40 ≤ T_A ≤ +85°C		25	316	µV/V
Supply Current/Amplifier	I_{SY}	V_O = 0 V, 40 ≤ T_A ≤ +85°C		210	250	µA
Supply Voltage Range	V_S		±4.5		±18	V
DYNAMIC PERFORMANCE						
Slew Rate	SR	R_L = 10 kΩ	7	9		V/µs
Full-Power Bandwidth	BW_P	1% Distortion		125		kHz
Settling Time	t_S	To 0.01%		1.6		µs
Gain Bandwidth Product	GBP			4		MHz
Phase Margin	$Ø_O$			55		Degrees
NOISE PERFORMANCE						
Voltage Noise	e_n p-p	0.1 Hz to 10 Hz		1.3		µV p-p
Voltage Noise Density	e_n	f = 1 kHz		36		nV/√Hz
Current Noise Density	i_n			0.01		pA/√Hz

NOTE
[1]The input bias and offset currents are tested at T_A = T_J = +85°C. Bias and offset currents are guaranteed but not tested at –40°C.

Specifications subject to change without notice.

WAFER TEST LIMITS (@ V_S = ±15.0 V, T_A = +25°C unless otherwise noted)

Parameter	Symbol	Conditions	Limit	Units
Offset Voltage	V_{OS}	OP282	3	mV max
Offset Voltage	V_{OS}	OP482	4	mV max
Input Bias Current	I_B	V_{CM} = 0 V	100	pA max
Input Offset Current	I_{OS}	V_{CM} = 0 V	50	pA max
Input Voltage Range[1]			–11, +15	V min/max
Common-Mode Rejection	CMRR	–11 V ≤ V_{CM} ≤ +15 V	70	dB min
Power Supply Rejection Ratio	PSRR	V = ±4.5 V to ±18 V	316	µV/V
Large Signal Voltage Gain	A_{VO}	R_L = 10 kΩ	20	V/mV min
Output Voltage Range	V_O	R_L = 10 kΩ	±13.5	V min
Supply Current/Amplifier	I_{SY}	V_O = 0 V, R_L = ∞	250	µA max

NOTES
Electrical tests and wafer probe to the limits shown. Due to variations in assembly methods and normal yield loss, yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualifications through sample lot assembly and testing.
[1]Guaranteed by CMR test.

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage . . . . . ±18 V
Input Voltage[1] . . . . . ±18 V
Differential Input Voltage[1] . . . . . 36 V
Output Short-Circuit Duration . . . . . Indefinite
Storage Temperature Range
P, S Packages . . . . . –65°C to +150°C
Operating Temperature Range
OP282A, OP482A . . . . . –55°C to +125°C
OP282G, OP482G . . . . . –40°C to +85°C
Junction Temperature Range
P, S Packages . . . . . –65°C to +125°C
Lead Temperature Range (Soldering, 60 sec) . . . . . +300°C

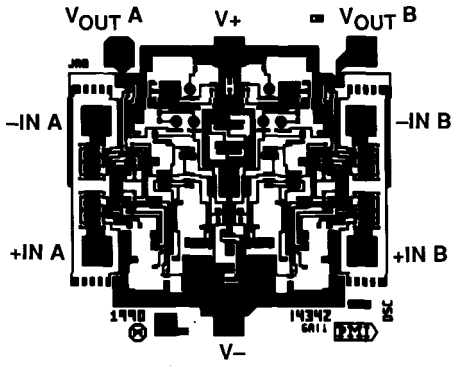
Package Type	θ_{JA}[2]	θ_{JC}	Units
8-Pin Plastic DIP (P)	103	43	°C/W
8-Pin SOIC (S)	158	43	°C/W
14-Pin Plastic DIP (P)	83	39	°C/W
14-Pin SOIC (S)	120	36	°C/W

NOTES
[1]For supply voltages less than ±18 V, the absolute maximum input voltage is equal to the supply voltage.
[2]θ_{JA} is specified for the worst case conditions, i.e., θ_{JA} is specified for device in socket for cerdip, P-DIP; θ_{JA} is specified for device soldered in circuit board for SOIC package.

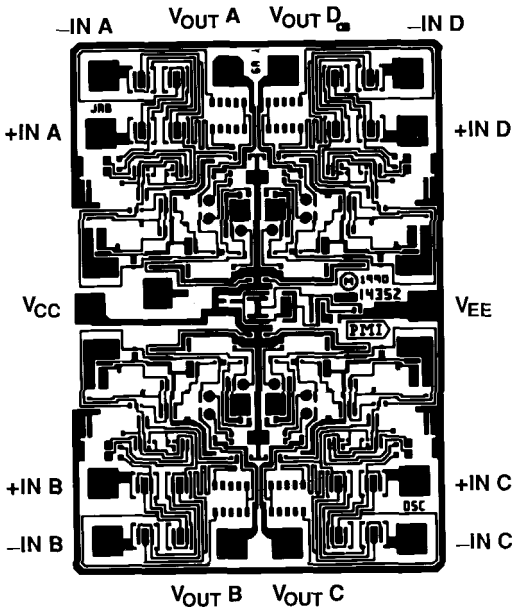
ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
OP282GP	–40°C to +85°C	8-Pin Plastic DIP	N-8
OP282GS	–40°C to +85°C	8-Pin SOIC	SO-8
OP482GP	–40°C to +85°C	14-Pin Plastic DIP	N-14
OP482GS	–40°C to +85°C	14-Pin SOIC	SO-14

DICE CHARACTERISTICS



OP282 Die Size 0.063 × 0.060 Inch, 3,780 Sq. Mils



OP482 Die Size 0.070 × 0.098 Inch, 6,860 Sq. Mils

APPLICATIONS INFORMATION

The OP282 and OP482 are single and dual JFET op amps that have been optimized for high speed at low power. This combination makes these amplifiers excellent choices for battery powered or low power applications requiring above average performance. Applications benefiting from this performance combination include telecom, geophysical exploration, portable medical equipment and navigational instrumentation.

HIGH SIDE SIGNAL CONDITIONING

There are many applications that require the sensing of signals near the positive rail. OP282s and OP482s have been tested and guaranteed over a common-mode range ($-11\ V \le V_{CM} \le +15\ V$) that includes the positive supply.

One application where this is commonly used is in the sensing of power supply currents. This enables it to be used in current sensing applications such as the partial circuit shown in Figure 1. In this circuit, the voltage drop across a low value resistor, such as the 0.1 Ω shown here, is amplified and compared to 7.5 volts. The output can then be used for current limiting.

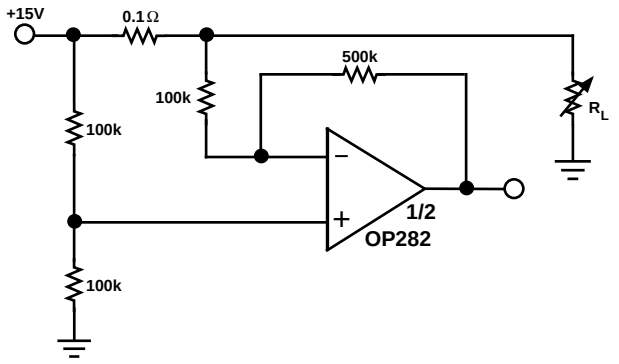


Figure 1. Phase Inversion

PHASE INVERSION

Most JFET-input amplifiers will invert the phase of the input signal if either input exceeds the input common-mode range. For the OP282 and OP482 negative signals in excess of approximately 14 volts will cause phase inversion. The cause of this effect is saturation of the input stage leading to the forward-biasing of a drain-gate diode. A simple fix for this in noninverting applications is to place a resistor in series with the noninverting input. This limits the amount of current through the forward-biased diode and prevents the shutting down of the output stage. For the OP282/OP482, a value of 200 kΩ has been found to work. However, this adds a significant amount of noise.

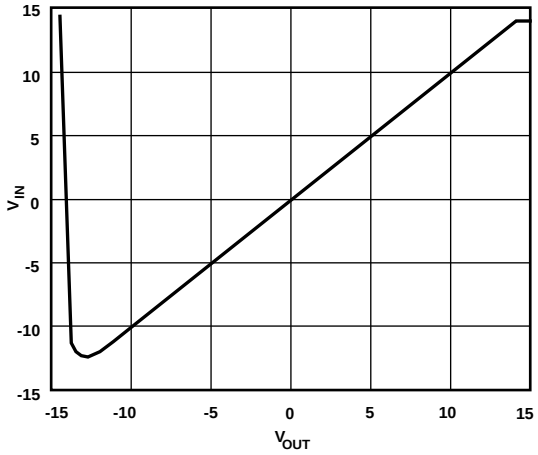


Figure 2. OP282 Phase Reversal

ACTIVE FILTERS

The OP282 and OP482's wide bandwidth and high slew rates make either an excellent choice for many filter applications.

There are many types of active filter configurations, but the four most popular configurations are Butterworth, elliptical, Bessel, and Chebyshev. Each type has a response that is optimized for a given characteristic as shown in Table I.

PROGRAMMABLE STATE-VARIABLE FILTER

Table I.

Type	Selectivity	Overshoot	Phase	Amplitude (Pass Band)	Amplitude (Stop Band)
Butterworth	Moderate	Good		Max Flat	
Chebyshev	Good	Moderate	Nonlinear	Equal Ripple	
Elliptical	Best	Poor		Equal Ripple	Equal Ripple
Bessel (Thompson)	Poor	Best	Linear		

The circuit shown in Figure 3 can be used to accurately program the "Q," the cutoff frequency f_C, and the gain of a two pole state-variable filter. OP482s have been used in this design because of their high bandwidths, low power and low noise. This circuit takes only three packages to build because of the quad configuration of the op amps and DACs.

The DACs shown are all used in the voltage mode so all values are dependent only on the accuracy of the DAC and not on the absolute values of the DAC's resistive ladders. This make this circuit unusually accurate for a programmable filter.

Adjusting DAC 1 changes the signal amplitude across R1; therefore, the DAC attenuation times R1 determines the amount of signal current that charges the integrating capacitor, C1. This cutoff frequency can now be expressed as:

$$fc = \frac{1}{2\pi R_1 C_1}\left(\frac{D_1}{256}\right)$$

where D_1 is the digital code for the DAC.

Gain of this circuit is set by adjusting D_3. The gain equation is:

$$Gain = \frac{R_4}{R_5}\left(\frac{D_3}{256}\right)$$

DAC 2 is used to set the "Q" of the circuit. Adjusting this DAC controls the amount of feedback from the bandpass node to the input summing node. Note that the digital value of the DAC is in the numerator, therefore zero code is not a valid operating point.

$$Q = \frac{R_2}{R_3}\left(\frac{256}{D_2}\right)$$

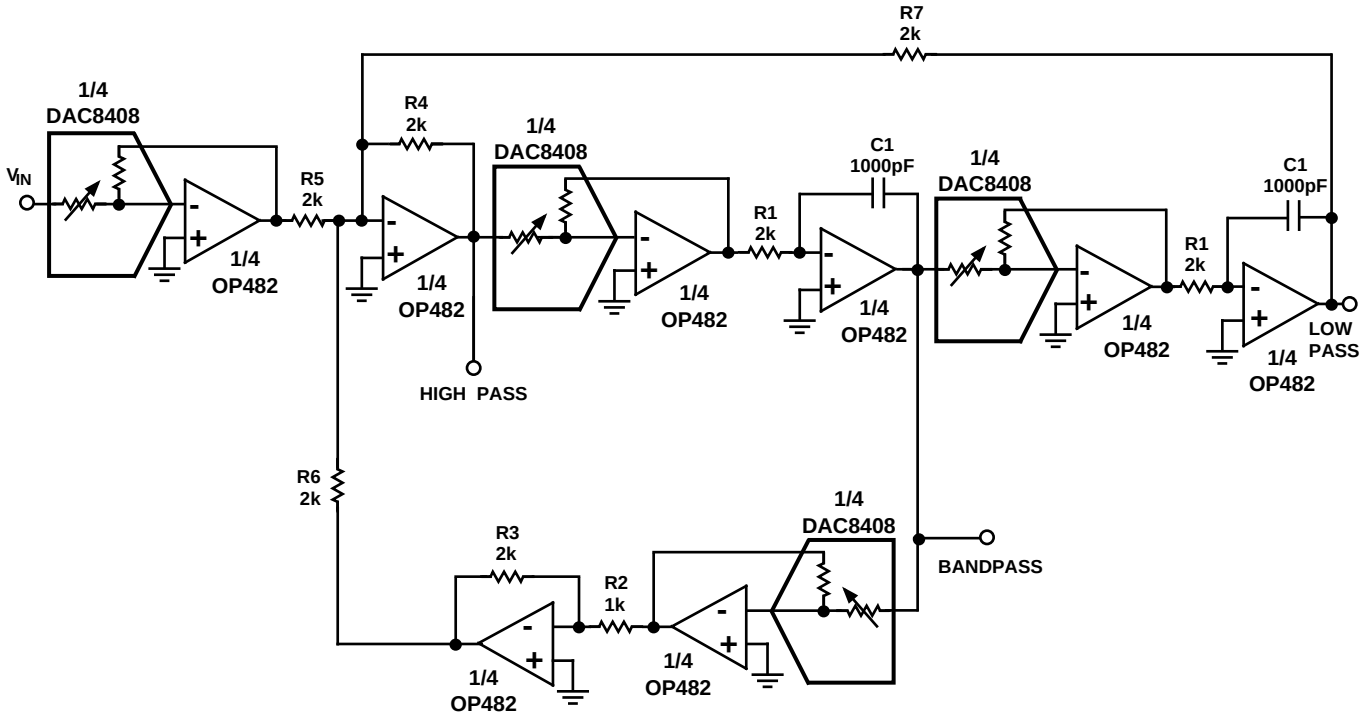


Figure 3.

OP282/OP482 SPICE MACRO MODEL

Figure 4 shows the OP282 SPICE macro model. The model for the OP482 is similar to that of the OP282, but there are some minor changes in the circuit values. Contact ADI for a copy of the latest SPICE model diskette for both listings.

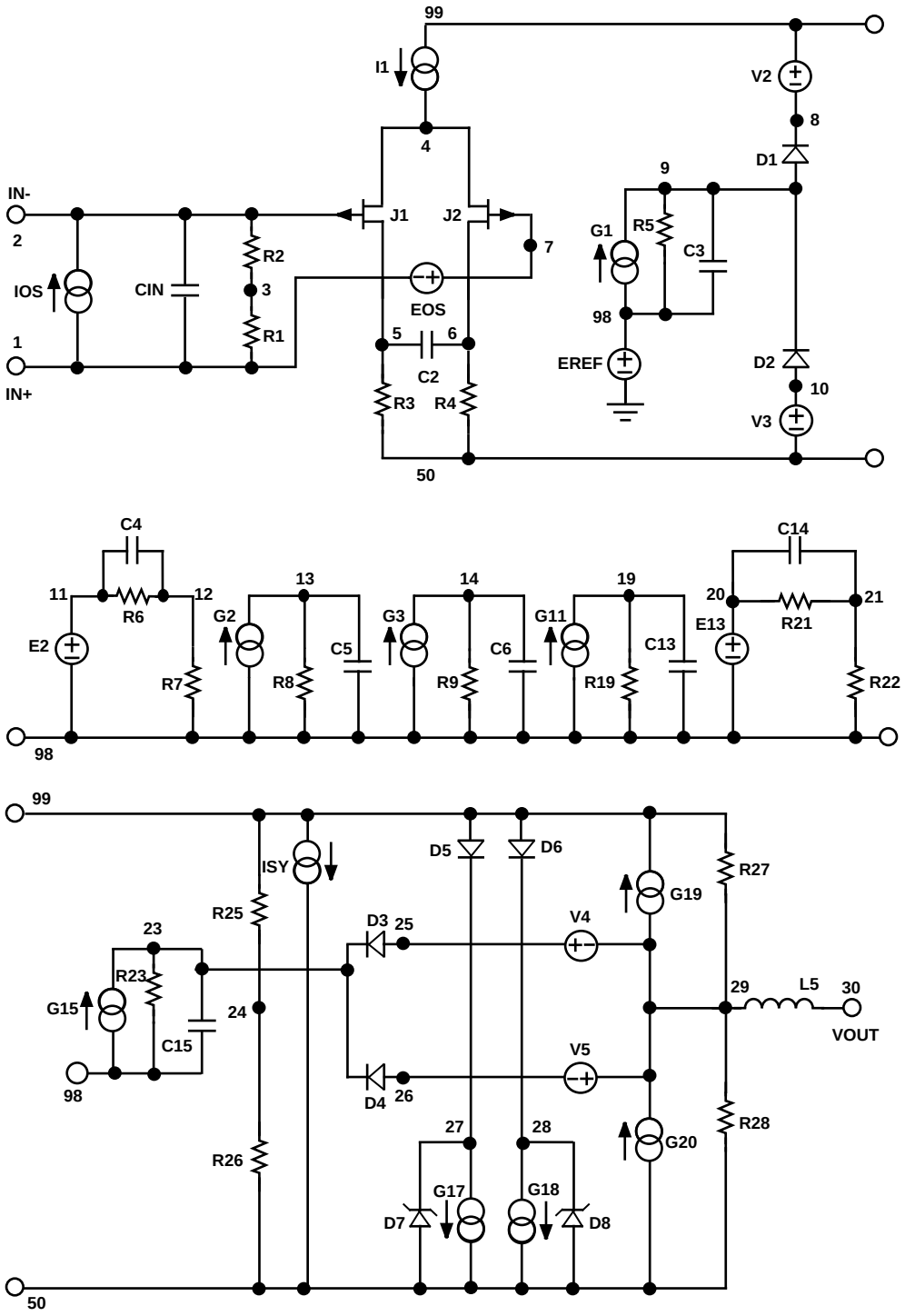


Figure 4.

OP282 SPICE MACRO MODEL

```
* Node assignments
*                    noninverting input
*                    |       inverting input
*                    |       |       positive supply
*                    |       |       |       negative supply
*                    |       |       |       |       output
*                    |       |       |       |       |
.SUBCKT OP282        1       2       99      50      30
*
* INPUT STAGE & POLE AT 15 MHZ
*
R1      1       3       5E11
R2      2       3       5E11
R3      5       50      3871.3
R4      6       50      3871.3
CIN     1       2       5E-12
C2      5       6       1.37E-12
I1      99      4       0.1E-3
IOS     1       2       5E-13
EOS     7       1       POLY(1) 21 24 200E-6 1
J1      5       2       4       JX
J2      6       7       4       JX
*
EREF    98      0       24      0 1
*
* GAIN STAGE & POLE AT 124 HZ
*
R5      9       98      1.16E8
C3      9       98      1.11E-11
G1      98      9       5 6     2.58E-4
V2      99      8       1.2
V3      10      50      1.2
D1      9       8       DX
D2      10      9       DX
*
* NEGATIVE ZERO AT 4 MHZ
*
R6      11      12      1E6
R7      12      98      1
C4      11      12      39.8E-15
E2      11      98      9       24 1E6
*
* POLE AT 15 MHZ
*
R8      13      98      1E6
C5      13      98      10.6E-15
G2      98      13      12      24 1E-6
*
* POLE AT 15 MHZ
*
R9      14      98      1E6
C6      14      98      10.6E-15
G3      98      14      13      24 1E-6
*
* POLE AT 15 MHZ
*
R19     19      98      1E6
C13     19      98      10.6E-15
G11     98      19      14      24 1E-6
*
* COMMON-MODE GAIN NETWORK
  WITH ZERO AT 11 KHZ
*
R21     20      21      1E6
R22     21      98      1
C14     20      21      14.38E-12
E13     98      20      3       24 31.62
*
* POLE AT 15 MHZ
*
R23     23      98      1E6
C15     23      98      10.6E-15
G15     98      23      19      24 1E-6
*
* OUTPUT STAGE
*
R25     24      99      5E6
R26     24      50      5E6
ISY     99      50      107E-6
R27     29      99      700
R28     29      50      700
L5      29      30      1E-8
G17     27      50      23      29 1.43E-3
G18     28      50      29      23 1.43E-3
G19     29      99      99      23 1.43E-3
G20     50      29      23      50 1.43E-3
V4      25      29      2.8
V5      29      26      3.5
D3      23      25      DX
D4      26      23      DX
D5      99      27      DX
D6      99      28      DX
D7      50      27      DY
D8      50      28      DY
*
* MODELS USED
*
.MODEL JX PJF(BETA = 3.34E-4
VTO = –2.000 IS = 3E-12)
.MODEL DX D(IS = 1E-15)
.MODEL DY D(IS = 1E-15 BV = 50)
.ENDS OP282
```

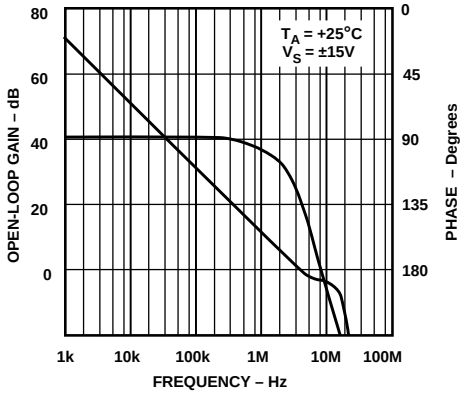


Figure 5. Open-Loop Gain, Phase vs. Frequency

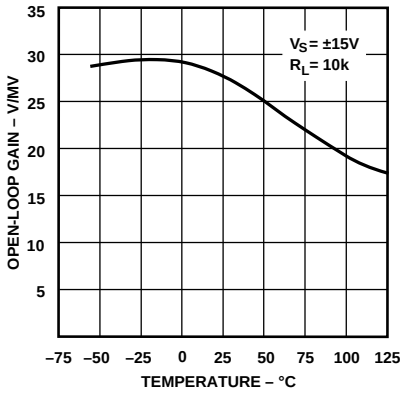


Figure 8. Open-Loop Gain (V/mV)

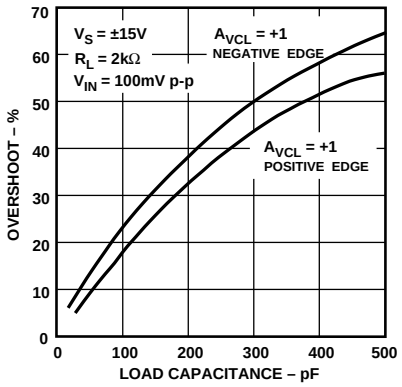


Figure 11. Small Signal Overshoot vs. Load Capacitance

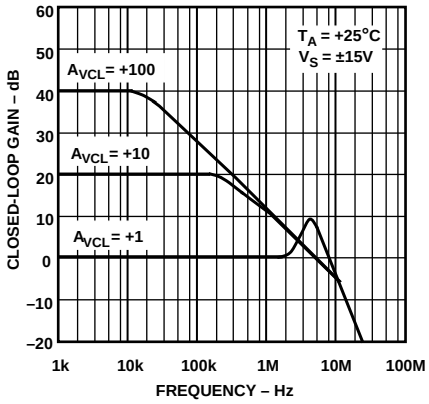


Figure 6. Closed-Loop Gain vs. Frequency

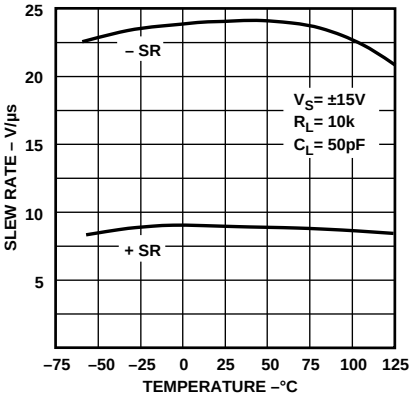


Figure 9. OP282/OP482 Slew Rate vs. Temperature

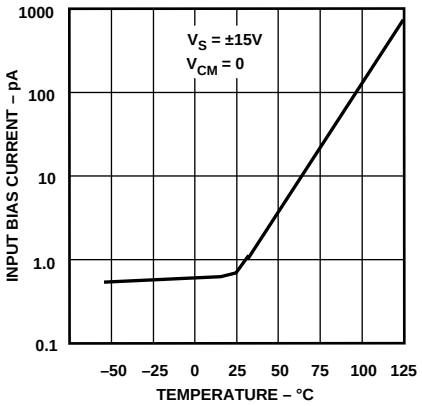


Figure 12. OP282 Input Bias Current vs. Temperature

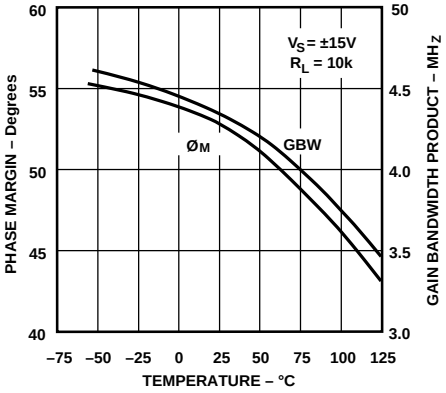


Figure 7. OP482 Phase Margin and Gain Bandwidth Product vs. Temperature

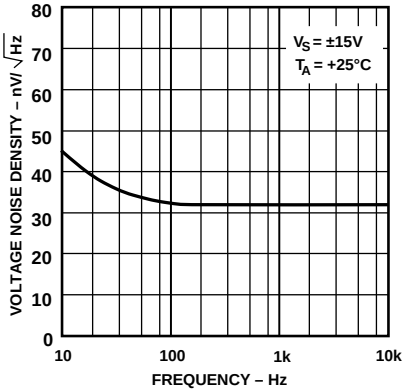


Figure 10. Voltage Noise Density vs. Frequency

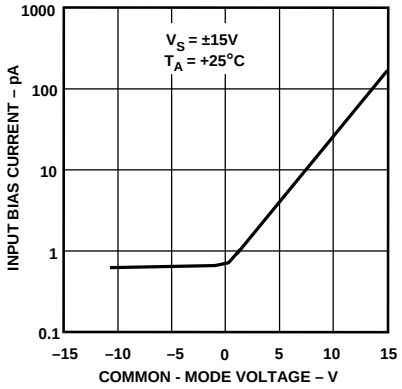


Figure 13. OP282 Input Bias Current vs. Common-Mode Voltage

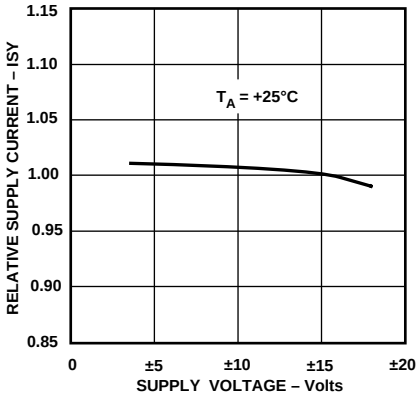


Figure 14. Relative Supply Current vs. Supply Voltage

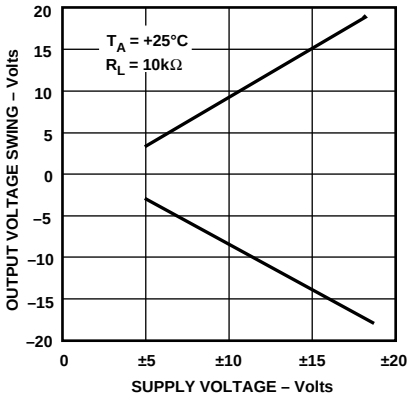


Figure 17. Output Voltage Swing vs. Supply Voltage

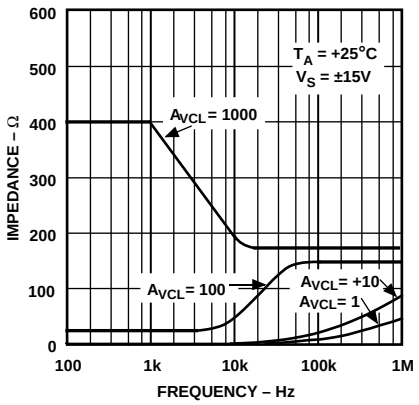


Figure 20. OP482 Closed-Loop Output Impedance vs. Frequency

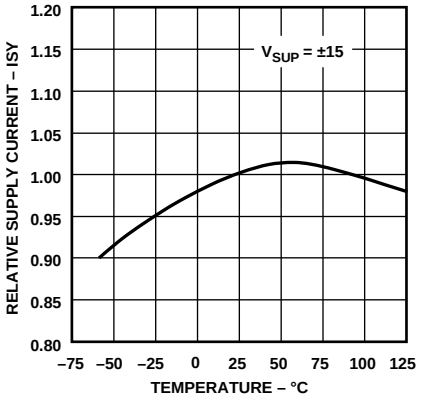


Figure 15. Relative Supply Current vs. Temperature

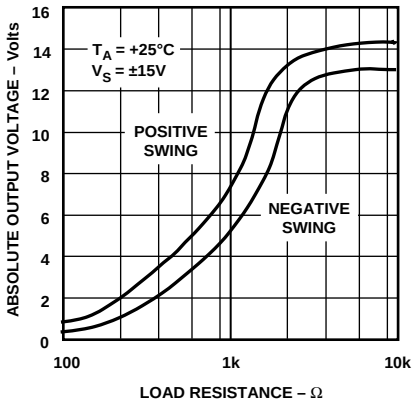


Figure 18. Maximum Output Voltage vs. Load Resistance

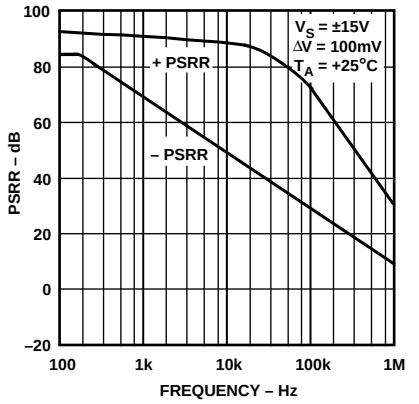


Figure 21. OP282 Power Supply Rejection Ratio (PSRR) vs. Frequency

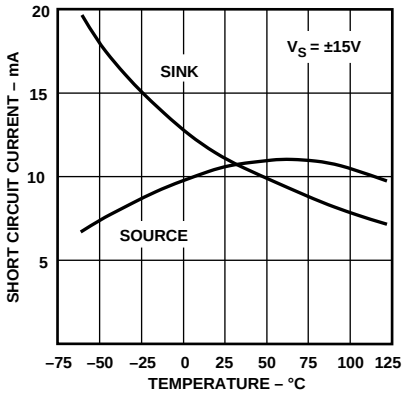


Figure 16. OP282/OP482 Short Circuit Current vs. Temperature

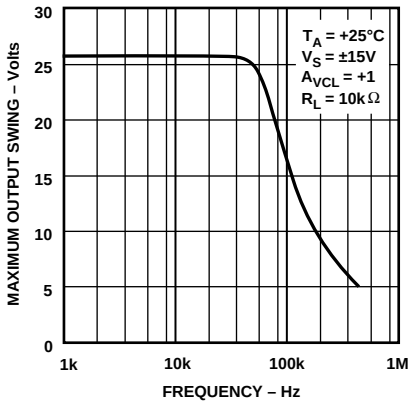


Figure 19. Maximum Output Swing vs. Frequency

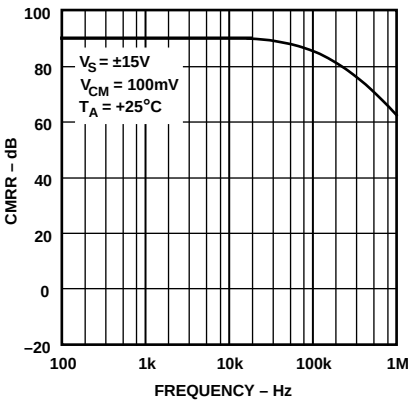


Figure 22. OP282 Common-Mode Rejection Ratio (CMRR) vs. Frequency

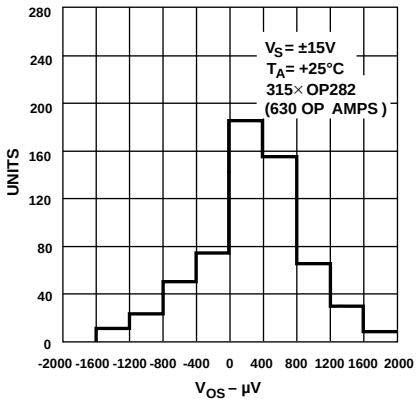


Figure 23. V_{OS} Distribution "P" Package

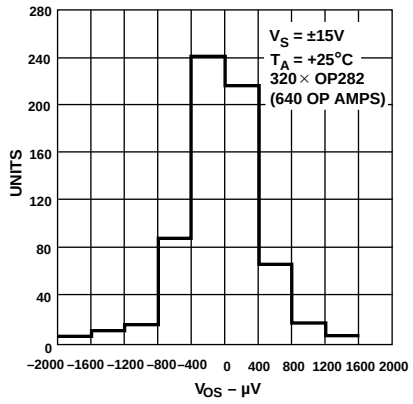


Figure 24. V_{OS} Distribution "Z" Package

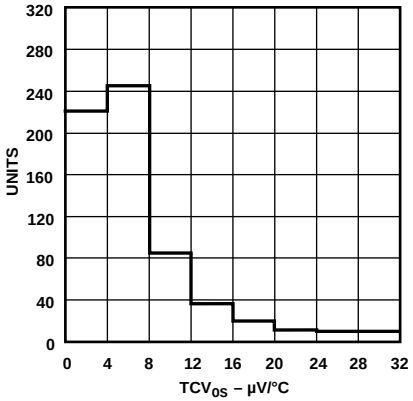


Figure 25. OP282 TCV_{OS} (µV/°C) Distribution "P" Package

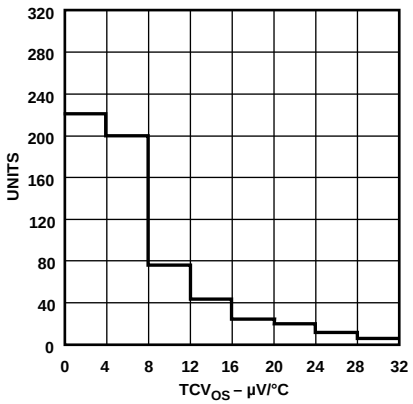


Figure 26. OP282 TCV_{OS} (µV/°C) Distribution "Z" Package

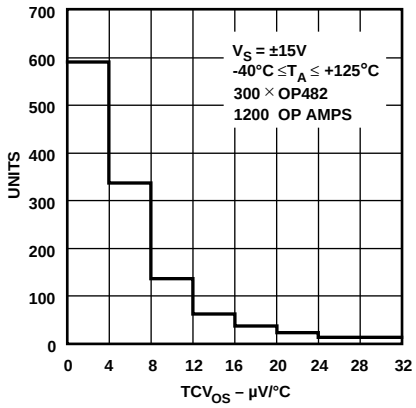


Figure 27. OP482 TCV_{OS} Distribution "Z" Package

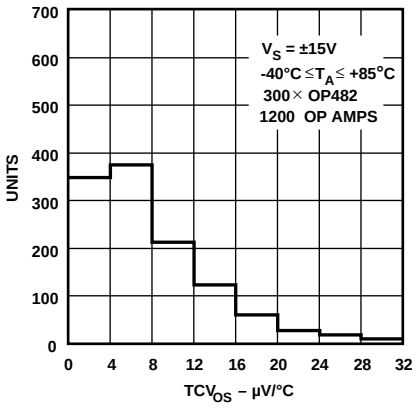


Figure 28. TCV_{OS} Distribution "P" Package

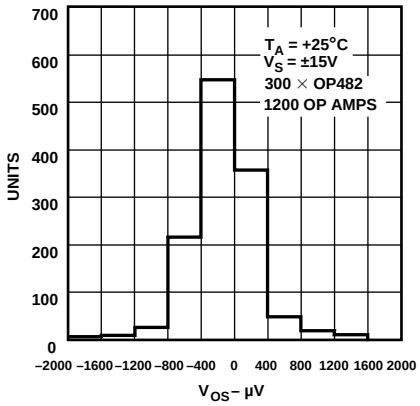


Figure 29. OP482 V_{OS} Distribution "Z" Package

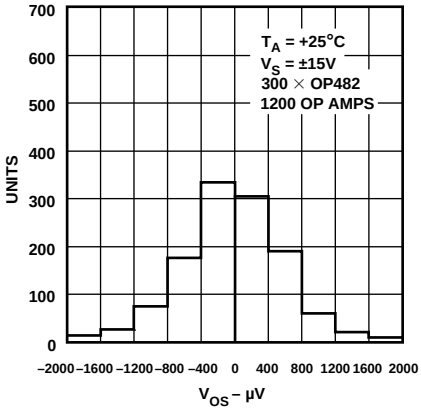
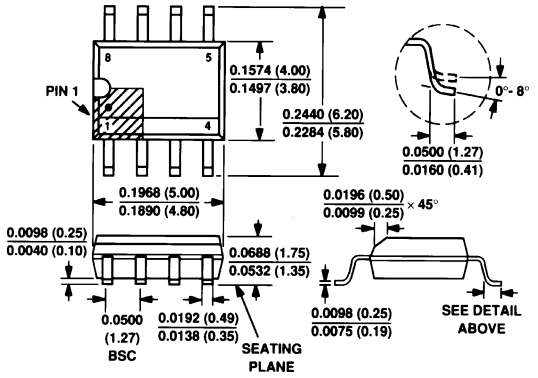


Figure 30. OP482 V_{OS} Distribution "P" Package

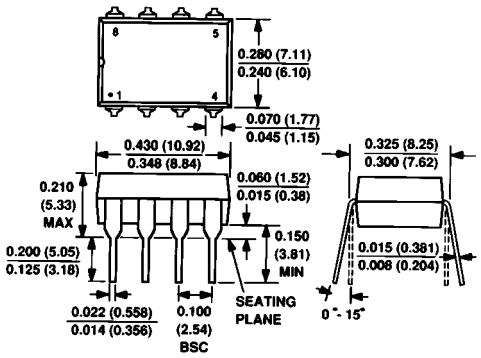
OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

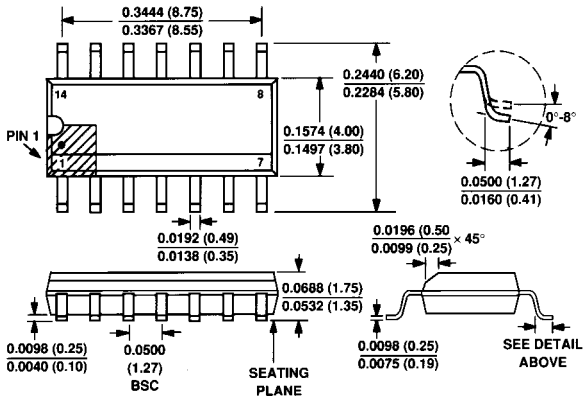
8-Lead Narrow-Body SOIC (S Suffix)



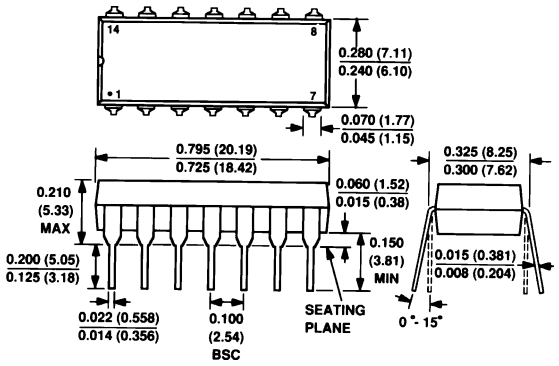
8-Lead Epoxy DIP (P Suffix)



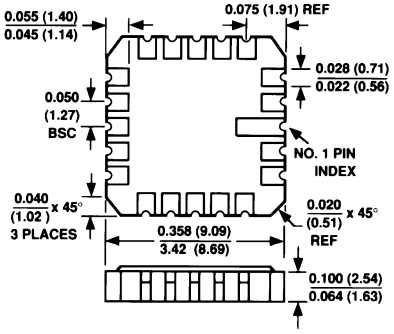
14-Lead Narrow-Body SOIC (S Suffix)



14-Lead Epoxy DIP (P Suffix)



20-Position Chip Carrier (RC Suffix)



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